

<b>Notice of References Cited</b>	Application/Control No. 10/577,940		Applicant(s)/Patent Under Reexamination LOHRAY, BRAJ	
	Examiner Celia Chang		Art Unit 1625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,291,735	11-2007	Mukarram et al.	546/114
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO2005/012300	02-2005	WO	Mukarram et al.	----
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**NON-PATENT DOCUMENTS**

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	U	Kirk-Othmer "crystallization" Encyclopedia of chem. tech. p.95-147 (2002)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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